Search Notes



Application/Control No.	Applicant(s)/Patent under Reexamination
09/698,712	YU ET AL.
Examiner	Art Unit
Christopher A. Revak	2131

SEARCHED			
Class	Subclass	Date	Examiner
NONE	NONE	3/7/2006	CR

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
713	168,176	11/14/2005	CR
382	181,190	11/14/2005	CR
382	191,232	11/14/2005	CR
380/200-203,205		11/14/2005	CR

SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
BRS Text Search USPAT, US PGPUB, USOCR, DERWENT, JPO, EPO, IBM TDB	3/7/2006	CR
DIALOG Text Search COMPSCI, ELECTRON, SOFTWARE	3/7/2006	CR
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Search Notes (continued)



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SEARCHED			
Class	Subclass	Date	Examiner
NONE	NONE	3/7/2006	CR
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
714	5,6,20	11/14/2005	CR
714	710,711	11/14/2005	CR
714	746,752	11/14/2005 CR	
714/758,766,770,804		11/14/2005	CR

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
DATE EX			
1			
N/A			